

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/791,734	WATANABE, NAOKI	WATANABE, NAOKI	
Examiner	Art Unit	Art Unit	
Patrick M. Moore	2188	2188	

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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Updated Classification and Text Searches to discover newly published matter since previous searching	8/2/2006	РММ
Interference Search [see: S59]	8/2/2006	РММ
Discussed Applicant's arguments and state of prior art with Primary Examiner [Gary Portka]	8/1/2006	РММ
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